Product data sheet

1. General description

Planar passivated Silicon Controlled Rectifier (SCR) in a TO220F "full pack" plastic package intended for use in applications requiring good bidirectional blocking voltage and high surge current capability and high junction temperature capability ($T_{j(max)} = 150$ °C).

2. Features and benefits

- High junction operating temperature capability (T_{j(max)} = 150 °C)
- Good blocking voltage capability
- · Very high surge current capability
- · High thermal cycling performance
- · Isolated mounting base package
- · Planar passivated for voltage ruggedness and reliability

3. Applications

- · Capacitive Discharge Ignition (CDI)
- Crowbar protection
- Inrush protection
- Motor control
- Voltage regulation

4. Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{DRM}	repetitive peak off-state voltage		-	-	800	V
I _{T(RMS)}	RMS on-state current	half sine wave; $T_h \le 68 ^{\circ}\text{C}$; Fig. 1; Fig. 2; Fig. 3	-	-	20	А
I _{TSM}	non-repetitive peak on- state current	half sine wave; $T_{j(init)} = 25 \text{ °C}$; $t_p = 10 \text{ ms}$; Fig 4; Fig 5	-	-	225	А
		half sine wave; $T_{j(init)} = 25 \text{ °C}$; $t_p = 8.3 \text{ ms}$	-	-	248	Α
T _j	junction temperature		-	-	150	°C
Static ch	aracteristics					
I _{GT}	gate trigger current	$V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; T_j = 25 \text{ °C}; Fig. 7$	-	-	6.2	mA
I _H	holding current	V _D = 12 V; T _j = 25 °C; <u>Fig. 9</u>	-	-	40	mA
V _T	on-state voltage	$I_T = 20 \text{ A}; \ T_j = 25 \text{ °C}; \underline{\text{Fig. 10}}$	-	-	1.6	V
Dynamic	characteristics			,		
dV _D /dt	rate of rise of off-state voltage	V _{DM} = 402 V; T _j = 150 °C; exponential waveform; gate open circuit	300	-	-	V/µs

SCR

5. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	K	cathode	mb	
2	А	anode		A K
3	G	gate		sym037
mb	n.c.	mounting base; isolated		
			1 2 3	

6. Ordering information

Table 3. Ordering information

Type number	Package Name	Orderable part number	Packing method	Small packing quantity	Package version	Package issue date
TYN20X-800TF	TO220F	TYN20X-800TFQ	Tube	50	SOT186A	14-Nov-2013

7. Marking

Table 4. Marking codes

Type number	Marking codes
TYN20X-800TF	TYN20X 800TF

8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DRM}	repetitive peak off-state voltage		-	800	V
V_{RRM}	repetitive peak reverse voltage		-	800	V
I _{T(AV)}	average on-state current	half sine wave; T _h ≤ 68 °C	-	12.7	Α
$I_{T(RMS)}$	RMS on-state current	half sine wave; T _h ≤ 68 °C; Fig. 1; Fig. 2; Fig. 3	-	20	А
I _{TSM}	non-repetitive peak on- state current	half sine wave; $T_{j(init)}$ = 25 °C; t_p = 10 ms; Fig 4; Fig 5	-	225	А
		half sine wave; $T_{j(init)}$ = 25 °C; t_p = 8.3 ms	-	248	Α
I ² t	I ² t for fusing	t _p = 10 ms; sine-wave pulse	-	254	A ² s
dl _⊤ /dt	rate of rise of on-state current	I _G = 20 mA	-	125	A/µs
I _{GM}	peak gate current		-	4	Α
V_{GM}	peak gate voltage		-	5	V
P_{GM}	peak gate power		-	20	W
$P_{G(AV)}$	average gate power	over any 20 ms period	-	1	W
T _{stg}	storage temperature		-40	150	°C
T _j	junction temperature		-	150	°C

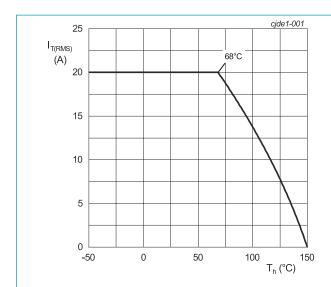
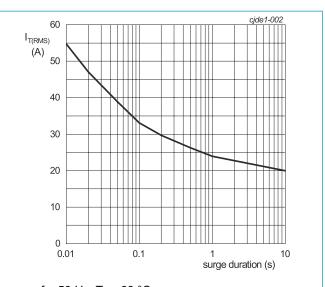
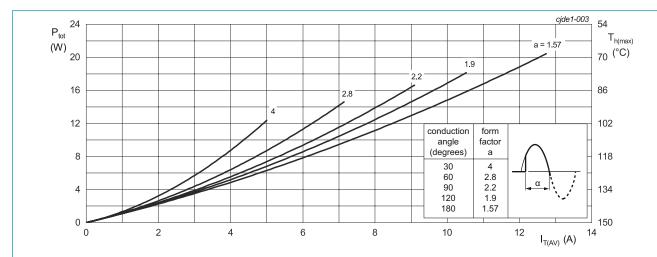


Fig. 1. RMS on-state current as a function of heatsink temperature; maximum values



f = 50 Hz; T_h = 68 °C
Fig. 2. RMS on-state current as a function of surge duration; maximum values



 α = conduction angle

 $a = form \ factor = I_{T(RMS)}/I_{T(AV)} \\$ Fig. 3. Total power dissipation as a function of RMS on-state current; maximum values

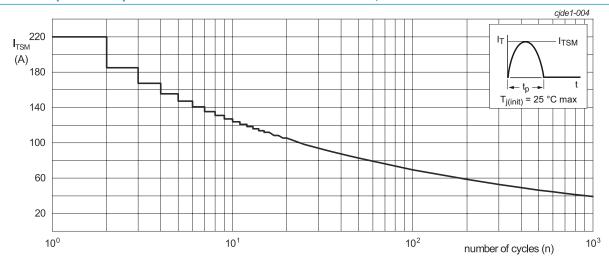
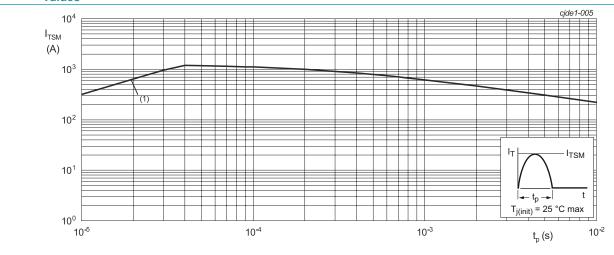


Fig. 4. Non-repetitive peak on-state current as a function of the number of sinusoidal current cycles; maximum values



 $t_p \le 10 \text{ ms}$

f = 50 Hz

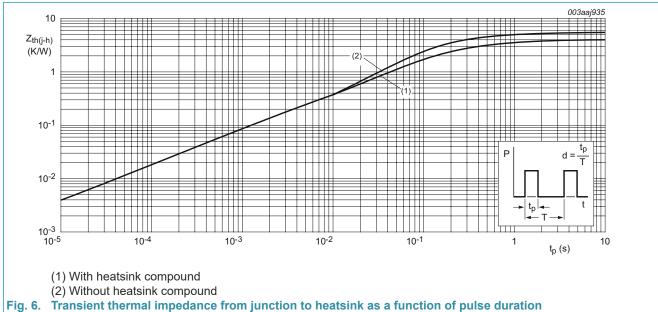
 $(1) dI_{T}/dt limit$

Non-repetitive peak on-state current as a function of pulse duration; maximum values

9. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-h)}	thermal resistance	with heatsink compound; Fig 6	-	-	4	K/W
	from junction to heatsink	without heatsink compound	-	-	5.5	K/W
R _{th(j-a)}	thermal resistance from junction to ambient	in free air	-	55	-	K/W



10. Isolation characteristics

Table 7. Isolation characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{isol(RMS)}$	RMS isolation voltage	50 Hz ≤ f ≤ 60 Hz; RH ≤ 65 %; from all pins to external heatsink; sinusoidal waveform; clean and dust free	-	-	2500	V
C _{isol}	isolation capacitance	f = 1 MHz; T _h = 25 °C; from cathode to external heatsink	-	10	-	pF

11. Characteristics

Table 8. Characteristics

able o. Ci	laracteristics						
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Static cha	racteristics		,				
I _{GT}	gate trigger current	$V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; T_j = 25 \text{ °C}; Fig. 7$		-	-	6.2	mA
IL	latching current	$V_D = 12 \text{ V}; I_G = 0.1 \text{ A}; T_j = 25 \text{ °C}; Fig. 8$		-	-	60	mA
I _H	holding current	V _D = 12 V; T _j = 25 °C; <u>Fig. 9</u>		-	-	40	mA
V _T	on-state voltage	I _T = 20 A; T _j = 25 °C; <u>Fig. 10</u>		-	-	1.6	V
V_{GT}	gate trigger voltage	$V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; T_j = 25 \text{ °C}; Fig. 11$		-	0.75	1	V
		V _D = 400 V; I _T = 0.1 A;T _j = 150 °C		0.25	0.4	-	V
I _D	off-state current	V _D = 800 V; T _j = 150 °C		-	-	1	mA
I _R	reverse current	V _D = 800 V; T _j = 150 °C		-	-	1	mA
Dynamic	characteristics						
dV _D /dt	rate of rise of off-state voltage	V_{DM} = 402 V; T_j = 150 °C; exponential waveform; gate open circuit		300	-	-	V/µs
		V_{DM} = 536 V; R_{GK} = 100 Ω; T_j = 150 °C; $(V_{DM}$ = 67% of V_{DRM}); exponential waveform		500	-	-	V/µs
t _{gt}	gate-controlled turn-on time	$I_{TM} = 20 \text{ A}; V_D = 800 \text{ V}; I_G = 100 \text{ mA};$ $(dI_G/dt)_M = 5 \text{ A}/\mu\text{s}; T_j = 25 ^{\circ}\text{C}$		-	2	-	μs
t _q	commutated turn-off time	$I_{TM} = 2 \text{ A}; t_p = 50 \mu\text{s}; dV_D/dt = 5 V/\mu\text{s}; dI/dt = 30 A/\mu\text{s}$		-	-	12	μs

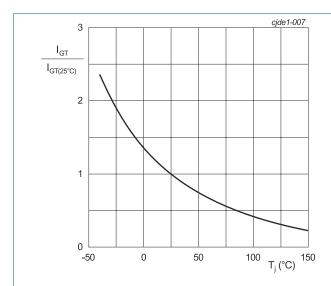


Fig. 7. Normalized gate trigger current as a function of junction temperature

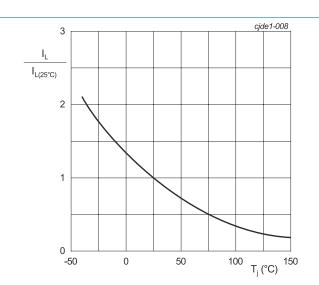


Fig. 8. Normalized latching current as a function of junction temperature

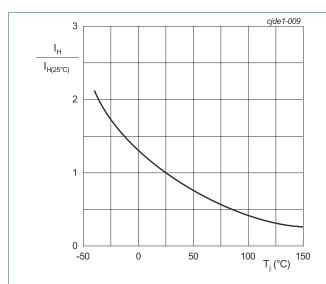
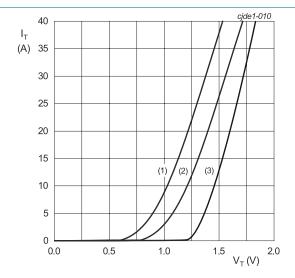


Fig. 9. Normalized holding current as a function of junction temperature



 $\begin{array}{l} V_o=1.041~V;~R_s=0.0179~\Omega\\ (1)~T_j=150~^{\circ}C;~typical~values\\ (2)~T_j=150~^{\circ}C;~maximum~values\\ (3)~T_j=25~^{\circ}C;~maximum~values \end{array}$

Fig. 10. On-state current as a function of on-state voltage

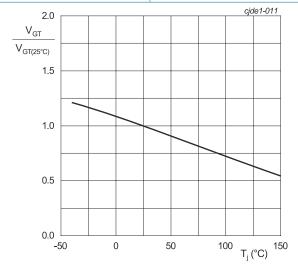


Fig. 11. Normalized gate trigger voltage as a function of junction temperature

12. Package outline

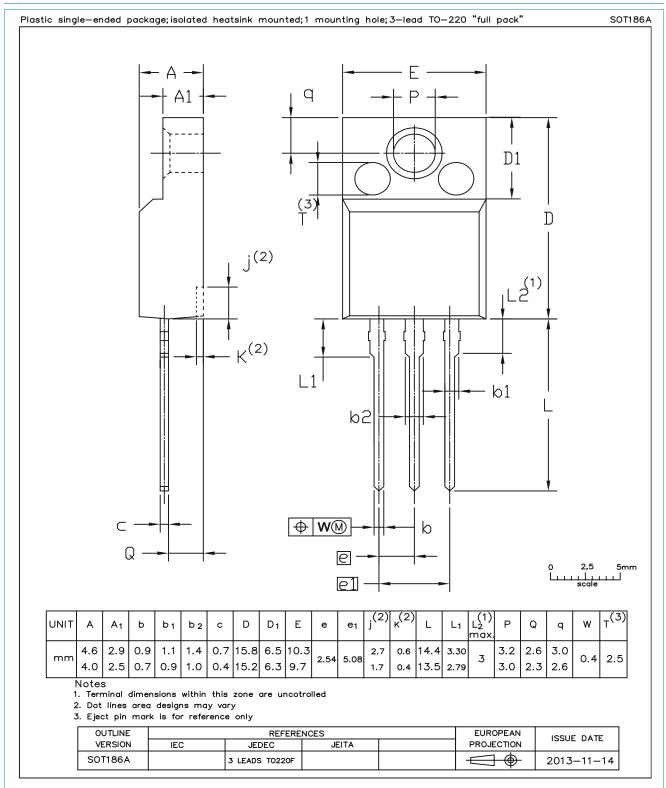


Fig. 12. Package outline TO220F

13. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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